

EddyCus® lab 2020HF – High Frequency Thin Film Tester

P T 2020HF 2



Highlights

- ► Contact-free and realtime
- ► Accurate single-point measurement
- Manual mapping guided by easy-tohandle software
- ► Measurement of encapsulated layers
- Complex impedance analysis for separation of electric, dielectric and magnetic properties

Applications

- Composition assessment of electric, dielectric, magnetic properties
- ▶ Printing
- ► Impregnation
- Drying
- ► Curing
- ► Chemical reaction monitoring
- Mixing
- ▶ Sorting
- ▶ Defect analysis (anomalies, hot spots)

Device Series

- ► Wet thickness (µm) / weight (g/m²)
- ▶ Drying status (%)
- ▶ Permittivity (F/m) Beta
- ► Conductivity / resistivity (mOhm·cm)
- ▶ Permeability (H/m) Beta
- ► Sheet resistance (Ohm/sq)
- ► Electrical anisotropy (%)
- Metal thickness (nm, μm)

Materials

- ► Wet thin films and surfaces
- Wet components and structures
- ► Liquids, slurries, inks, resigns, dispersions, chemicals
- Powders and particle films (cosmetics and medicines)
- ► Bulk materials (plastics, ceramics)
- Composites (prepregs, impregnated fibers and tapes, CFRP)
- ► Compounds (casting compounds)

SURAGUS GmbH Maria-Reiche-Strasse 1 01109 Dresden Germany

For further questions: +49 351 32 111 520

sales@suragus.com

Visit us at:
www.suragus.com
www.suragus.com/calculator
www.suragus.com/EddyCusLab2020

Engineered and Made in Germany





Working Principle

- ► EddyCus® sensors generate electromagnetic fields (EMFs)
- ► EMFs change when material with electric, dielectric and /or (ferro)magnetic properties is present
- ► The evaluation of the resulting change in the EMF provide

information on

- ► Conductivity (e.g. metals, semiconductors, graphite)
- ► Permeability (e.g. Co, Ni, Fe)
- ▶ Permittivity (e.g. water, solvent, polymers, chemicals)
- ► Complex impedance analysis is used to separate properties

Device Characteristics

| Measurement technology | Non-contact high frequency eddy current sensor |
|------------------------------------|---|
| Substrates | Foils, glass, various containers |
| Substrate area | 8 inch / 204 mm x 204 mm (open on three sides) |
| Max. sample thickness/ sensor gap | Transmission setup: 3 – 50 mm (defined by the thickest sample) Reflection setups: infinite (only surface area is analyzed) |
| Measurement types | Wet thickness (μm) / weight (g/m²) / drying status (%) Conductivity / resistivity (mOhm·cm) / permeability (H/m) <i>Beta</i> Permittivity (F/m) <i>Beta</i> |
| Measurement range / accuracy | Depends on the measurement task, the material composition and the test object volume. Please consult the SURAGUS team |
| Device dimensions (w/h/d) / weight | 11.4" x 5.5" x 17.5" / 290 mm x 140 mm x 445 mm / 10 kg |
| Further available measurements | Sheet resistance, metal thickness, anisotropy |

Device Control and Software

